

<b>Notice of References Cited</b>	Application/Control No. 10/692,802	Applicant(s)/Patent Under Reexamination TAKABATAKE ET AL.	
	Examiner Gregory B. Sefcheck	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0182074 A1	08-2006	Kubler et al.	370/338
*	B	US-2005/0223115 A1	10-2005	Hanson et al.	709/245
*	C	US-2005/0118985	06-2005	Takabatake et al.	455/411
*	D	US-6,885,643	04-2005	Teramoto et al.	370/252
*	E	US-6,484,028 B2	11-2002	Okada et al.	455/428
*	F	US-6,483,852 B1	11-2002	Jacquet et al.	370/466
*	G	US-6,393,032 B1	05-2002	Ikegami, Yoshikazu	370/447
*	H	US-5,706,428 A	01-1998	Boer et al.	370/342
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.